Notice of References Cited

Application/Control No. 09/683,739	Applicant(s)/Patent Und Reexamination LU ET AL.	er
Examiner	Art Unit	
Akash Saxena	2128 Page	e 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0147576	10-2002	Hsu et al.	703/15
	В	US-5,220,512	06-1993	Watkins et al.	716/11
	С	US-5,379,231	01-1995	Pillage et al.	703/14
	D	US-5,442,772	08-1995	Childs et al.	703/13
	E	US-5,500,808	03-1996	Wang, Albert R.	703/19
	F	US-5,838,949	11-1998	Hassoun, Jean Andre	703/13
	G	US-5,956,261	09-1999	Blaauw et al.	703/14
	Н	US-6,026,222	02-2000	Gupta et al.	716/5
	ı	US-6,132,109	10-2000	Gregory et al.	703/14
	J	US-6,134,516	10-2000	Wang et al.	703/20
	к	US-6,363,520	03-2002	Boubezari et al. '	716/18
	L	US-6,789,242	09-2004	Liu, Lung-Chun	703/19
	м	US-2002/0111969	08-2002	Halstead, Robert H. JR.	707/517

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	"An Efficient Parallel Critical Path Algorithm";Li Ren Liu et al; IEEE Transactions on Computer Aided Desiggn of Integrated Circuits and Systems Vol.13 No.7 July 1994.					
	٧	"Efficient Algorithms for Extracting the K Most Critical Paths in Timing Analysis"; Steve H.C. Yen et al; 26th ACM/IEEE Design Automation Conference 1989.					
	W	"Vex - A CAD toolbox" ACM 1999					
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. O9/683,739 Examiner Art Unit Akash Saxena Applicant(s)/Patent Under Reexamination LU ET AL. Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0118193	08-2002	Halstead, Robert H. JR.	345/440
	В	US-2002/0147576	10-2002	Hsu et al.	703/15
	С	US-2002/0152060	10-2002	Tseng, Ping-Sheng	703/17
	D	US-2004/0230921	11-2004	Hathaway et al.	716/002
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name \	Classification
	N					
	0			•		
	Р			•		
	Q					4
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	U		
	٧	v		
	W	w		
	x	x		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.